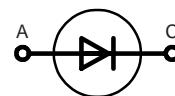


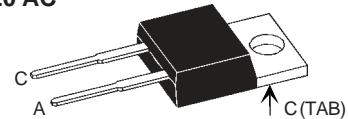
HiPerFRED™ Epitaxial Diode with soft recovery

Preliminary Data

V_{RSM}	V_{RRM}	Type
V	V	
200	200	DSEP 8-02A



TO-220 AC



A = Anode, C = Cathode, TAB = Cathode

D4

Symbol	Test Conditions	Maximum Ratings		Features
I_{FRMS}		35	A	
I_{FAVM}	$T_c = 150^\circ\text{C}$; rectangular, $d = 0.5$	8	A	
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t_p = 10 \text{ ms}$ (50 Hz), sine	80	A	
E_{AS}	$T_{VJ} = 25^\circ\text{C}$; non-repetitive $I_{AS} = 2 \text{ A}$; $L = 180 \mu\text{H}$	0.5	mJ	
I_{AR}	$V_A = 1.5 \cdot V_R \text{ typ.}$; $f = 10 \text{ kHz}$; repetitive	0.2	A	
T_{VJ}		-55...+175	°C	
T_{VJM}		175	°C	
T_{stg}		-55...+150	°C	
P_{tot}	$T_c = 25^\circ\text{C}$	60	W	
M_d	mounting torque	0.4...0.6	Nm	
Weight	typical	2	g	

Symbol	Test Conditions	Characteristic Values		Advantages
		typ.	max.	
I_R ①	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$ $T_{VJ} = 150^\circ\text{C}$ $V_R = V_{RRM}$	50 0.2	μA mA	
V_F ②	$I_F = 8 \text{ A}$; $T_{VJ} = 150^\circ\text{C}$ $T_{VJ} = 25^\circ\text{C}$	0.94 1.30	V V	
R_{thJC} R_{thCH}		0.5	K/W K/W	
t_{rr}	$I_F = 1 \text{ A}$; $-\frac{dI}{dt} = 50 \text{ A/s}$ $V_R = 30 \text{ V}$; $T_{VJ} = 25^\circ\text{C}$	25	ns	
I_{RM}	$V_R = 100 \text{ V}$; $I_F = 10 \text{ A}$; $-\frac{dI_F}{dt} = 100 \text{ A/s}$ $T_{VJ} = 100^\circ\text{C}$	4.1	A	

Recommended replacement:
DPG10I200PA

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0 %
② Pulse Width = 300 s, Duty Cycle < 2.0 %

Data according to IEC 60747 and per diode unless otherwise specified

IXYS reserves the right to change limits, test conditions and dimensions.

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